Sparch Notes

Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/712,452	HA ET AL.		
Examiner	Art Unit		
Tuan T. Lam	2816		

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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